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### Depth-resolved charge reconstruction at the LaNiO<sub>3</sub>/CaMnO<sub>3</sub> interface

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#### 1 Abstract

2 Rational design of low-dimensional electronic phenomena at oxide interfaces is currently considered to be one of the most promising schemes for realizing new energy-efficient logic and 3 memory devices. An atomically-abrupt interface between paramagnetic LaNiO<sub>3</sub> and 4 antiferromagnetic CaMnO<sub>3</sub> exhibits interfacial ferromagnetism, which can be tuned via a 5 thickness-dependent metal-insulator transition in LaNiO<sub>3</sub>. Once fully understood, such emergent 6 functionality could turn this archetypal Mott-interface system into a key building block for the 7 above-mentioned future devices. Here, we use depth-resolved standing-wave photoemission 8 spectroscopy in conjunction with scanning transmission electron microscopy and x-ray 9 absorption spectroscopy, to demonstrate a depth-dependent charge reconstruction at the 10 LaNiO<sub>3</sub>/CaMnO<sub>3</sub> interface. Our measurements reveal an increased concentration of Mn<sup>3+</sup> and 11 Ni<sup>2+</sup> cations at the interface, which create an electronic environment favourable for the 12 emergence of interfacial ferromagnetism mediated via the Mn<sup>4+</sup>-Mn<sup>3+</sup> ferromagnetic double 13 exchange and Ni<sup>2+</sup>-O-Mn<sup>4+</sup> superexchange mechanisms. Our findings suggest a new strategy for 14 designing functional Mott oxide heterostructures by tuning the interfacial cation characteristics 15 16 via controlled manipulation of thickness, strain, and ionic defect states.

1 Multifunctional complex-oxide heterostructures have been identified as candidate materials systems that may enable the coupling of electronic logic with magnetic memory and lead to the 2 next-generation of spintronic devices [1-5]. Among the many complex-oxide heterostructures 3 studied to date, there has been a class of heterostructures where the interfaces give rise to 4 functional properties not observed in the constituent materials [6]. With many such emergent 5 properties, ranging from interfacial metallicity [7-9] to interfacial superconductivity [10,11], 6 there has been only a handful of successful efforts demonstrating new magnetic ground states at 7 interfaces [12,13]. One such example is the LaNiO<sub>3</sub>/CaMnO<sub>3</sub> system where ferromagnetic 8 9 ground state emerges at the interface, although LaNiO<sub>3</sub> is a paramagnetic metal and CaMnO<sub>3</sub> is an antiferromagnetic insulator in the bulk [13-15]. 10

The emergence of interfacial ferromagnetism in the LaNiO<sub>3</sub>/CaMnO<sub>3</sub> system has been 11 attributed to two distinct mechanisms: a Mn<sup>4+</sup>-Mn<sup>3+</sup> double exchange interaction in the 12 interfacial CaMnO<sub>3</sub> layer and a Ni<sup>2+</sup>-O-Mn<sup>4+</sup> superexchange interaction at the interface between 13 the LaNiO<sub>3</sub> and CaMnO<sub>3</sub> [13-15]. The relative importance of the two mechanisms depends on 14 the thickness of the individual layers due to a thickness-dependent metal-insulator transition in 15 the LaNiO<sub>3</sub> layer [16-18]. The transition, which occurs in the ultrathin (few-unit-cell) limit, 16 determines which is the dominant mechanism for the mediation of the ferromagnetic coupling. 17 18 Such tunability provides an ideal platform for studying fundamental interactions leading to emergent magnetism at oxide interfaces and makes this heterostructure a potential candidate for 19 the above-mentioned devices. [12,19,20]. 20

Both of the above mentioned mechanisms require an interfacial charge reconstruction, which results in the presence of the transition-metal cations with the valence states other than the formal valence state of the stoichiometric compounds (LaNi<sup>3+</sup>O<sub>3</sub> and CaMn<sup>4+</sup>O<sub>3</sub>). Such charge

reconstruction, resulting in the formation of off-stoichiometric cations (Ni<sup>2+</sup> and Mn<sup>3+</sup>) at the 1 interface, can be explained in terms of the charge leakage from LaNiO<sub>3</sub> to CaMnO<sub>3</sub> [13-15], as 2 well as the presence of oxygen vacancies driven to the interface by polar compensation [21-24]. 3 Both scenarios are plausible in the LaNiO<sub>3</sub>/CaMnO<sub>3</sub> heterostructures. Specifically, in metallic 4 superlattices with near- and above-critical LaNiO<sub>3</sub> thicknesses, leakage of itinerant Ni 3d e<sub>o</sub> 5 electrons into the interfacial CaMnO<sub>3</sub> layer is expected to reduce the valence state of some of the 6 interfacial Mn cations from 4+ to 3+, leading to the emergence of interfacial ferromagnetism 7 mediated by the Mn<sup>4+</sup>-Mn<sup>3+</sup> double exchange interaction [13-15,25]. This scenario has been 8 theoretically predicted and discussed in-depth in prior experimental studies [13-15] and could 9 explain the observed link between the thickness-dependent metal-insulator transition in ultrathin 10 LaNiO<sub>3</sub> and the observed suppression of ferromagnetism in the superlattices with near- and 11 below-critical-thickness LaNiO<sub>3</sub> layers (see Fig. 2 in Ref. [15]). In superlattices with thinner 12 LaNiO<sub>3</sub>, which is closer to the metal-insulator transition and hence more resistive transport 13 properties, Ni<sup>2+</sup>-O-Mn<sup>4+</sup> superexchange interaction (made possible by oxygen vacancies driven 14 to the interface) has been identified as the source of the interfacial ferromagnetism [14,15]. On 15 the other hand, oxygen vacancies have also been observed in coherently strained epitaxial 16 CaMnO<sub>3</sub> [21] and LaNiO<sub>3</sub> [22-24] and, in some cases, have been both predicted and observed to 17 segregate at the interfaces due to polar energetics at the interface [22,23]. 18

Gaining a clear picture of the depth-dependent evolution of materials' electronic properties, valence states, and charge redistribution across the interface is therefore required to determine the roles of double exchange and superexchange interactions in the emergence of the observed interfacial ferromagnetism in this system. Thus, here, we used a combination of depth-resolved soft x-ray standing-wave photoemission spectroscopy (SW-XPS), x-ray absorption spectroscopy (XAS), and scanning transmission electron microscopy (STEM) to selectively probe the interface
electronic structure and valence states of the relevant transition metal cations (Mn and Ni). Our
results reveal an increased concentration of Mn<sup>3+</sup> and Ni<sup>2+</sup> cations at the LaNiO<sub>3</sub>/CaMnO<sub>3</sub>
interface, indicating the coexistence of competing Mn<sup>3+</sup>-Mn<sup>4+</sup> double exchange with Ni<sup>2+</sup>-OMn<sup>4+</sup> superexchange interactions that give rise to emergent interfacial ferromagnetism.

For this study, high-quality epitaxial [4 u.c. LaNiO<sub>3</sub> / 4 u.c. CaMnO<sub>3</sub>]×15 superlattice was 6 synthesized on top of a single-crystalline LaAlO<sub>3</sub> (001) substrate using pulsed laser deposition. 7 Layer-by-layer growth was monitored in-situ using reflection high-energy electron diffraction. 8 After deposition, coherent epitaxy, crystallinity and layering of the superlattice was verified 9 10 using ex-situ x-ray diffraction spectroscopy (XRD), soft x-ray reflectivity (SXR), as well as STEM (see Fig. 1). Bulk magnetization and electronic transport measurements, carried out by us 11 in a prior study on similar samples [15], revealed a ferromagnetic signal (0.3 µB/Int.Mn at 10 K) 12 and temperature-dependent resistivity ( $4 \times 10^{-4}$  Ohm-cm at 10 K), which is consistent with the 13 onset of metallicity in LaNiO<sub>3</sub>. More details regarding the deposition process and sample 14 characterization can be found in Ref. [15]. 15

A high-angular-resolution (<0.01°) XRD 2θ-θ spectrum in Fig. 1(a), recorded using a</li>
Bruker D8 Discover diffractometer, shows well-resolved superlattice (SL) period thickness
fringes and Bragg peaks, thus attesting to the high quality and precise control of the SL
synthesis. A high-angular-resolution (<0.01°) SXR spectrum (see inset), recorded at the</li>
Calibration and Standards beamline 6.3.2 of the Advanced Light Source (LBNL), confirms the
presence and the angular position of the SL Bragg peak in the soft x-ray regime at the photon
energy used for the SX-XPS measurements described below.



FIG. 1. (a) XRD 20-0 spectrum around the LaAlO<sub>3</sub> (002) peak shows clearly-resolved SL thickness fringes, as well as the first-order SL Bragg peaks. Inset shows a synchrotron-based SXR spectrum (at hv =832.8 eV) of the first-order superlattice Bragg peak in the soft x-ray regime. (b) High-resolution STEM-HAADF cross sectional image of the superlattice sample showing a typical atomically-abrupt LaNiO<sub>3</sub>/CaMnO<sub>3</sub> interface. (c) and (d) The XAS spectra probing the CaMnO<sub>3</sub> layer at the Mn  $L_{2,3}$ absorption edges (c), and the LaNiO<sub>3</sub> layer at the Ni  $L_2$  edge (d) reveal mixed valence states for the Mn (3+ and 4+) and Ni (2+ and 3+) cations in the respective layers.

1 At the atomic level, the high-angle annular dark-field (HAADF) STEM image in Fig. 1(b), recorded using the aberration-corrected TEAM I microscope at the National Center for Electron 2 Microscopy Facility of the Molecular Foundry (LBNL), shows several typical atomically-abrupt 3 4 interfaces between LaNiO<sub>3</sub> and CaMnO<sub>3</sub>. The A-site (La and Ca) atomic columns can be easily differentiated due to the high atomic number contrast, with the heavier cations (La) appearing 5 brighter. The interfacial layers show some fluctuations in atomic column intensity of the A-sites, 6 7 suggesting that the interfacial mixing is confined to a single unit cell, consistent with a prior study on similar samples [13]. 8

9 The high-resolution (100 meV) XAS spectra of the Mn  $L_{2,3}$  and Ni  $L_2$  absorption edges, 10 recorded in the total electron yield (TEY) detection mode at the Magnetic Spectroscopy 11 beamline of the Advanced Light Source (LBNL) [26], reveal fine spectral features attributed to 12 the Mn<sup>3+</sup> and Mn<sup>4+</sup> cations at 640 eV and 643 eV, respectively [Fig. 1(c)] [21]; as well as the Ni<sup>2+</sup> (869.5 eV) and Ni<sup>3+</sup> (870.5 eV) peak components at the Ni  $L_2$  edge [Fig. 1(d)] [27-29]. The data thus suggest a mixture of Mn<sup>3+</sup> and Mn<sup>4+</sup> cations originating in the CaMnO<sub>3</sub> layer and a mixture of Ni<sup>2+</sup> and Ni<sup>3+</sup> cations originating in the LaNiO<sub>3</sub> layer. However, XAS-TEY is a depthaveraging spectroscopic technique with a typical probing depth of 5 nm [30,31], and thus does not provide a depth-resolved valence-state profile of the structure with sufficient resolution.

Thus, in order to selectively probe the electronic structure and valence-states of the Mn and 6 Ni cations at the LaNiO<sub>3</sub>/CaMnO<sub>3</sub> interface, we have carried out soft x-ray SW-XPS 7 measurements at the high-resolution ADRESS beamline of the Swiss Light Source [32,33]. The 8 SX-ARPES end station at the ADRESS beamline was equipped with a SPECS PHOIBOS-150 9 10 hemispherical electrostatic analyzer and a six-axis cryogenic manipulator, allowing for optimal alignment of the sample and high-precision angle-resolved standing-wave measurements. The 11 above mentioned measurements were accomplished by setting-up an x-ray standing-wave field 12 within the periodic [4 u.c. LaNiO<sub>3</sub> / 4 u.c. CaMnO<sub>3</sub>]×15 superlattice sample, which in first-order 13 Bragg reflection acted as the standing-wave generator [see Fig. 2(a)]. The antinodes of the 14 standing wave were moved vertically through the sample by scanning (rocking) the x-ray 15 incidence angle [34,35]. The sample temperature was set at 30 K. 16

The photon energy of 832.8 eV, just below the La  $3d_{5/2}$  absorption threshold, was used to maximize the x-ray reflectivity of the superlattice, which in-turn enhanced the standing-wave modulation amplitude. In preparation for the experiment, energy-dependent SXR measurements were carried out to fine-tune the experimental parameters, such as the optimal photon energy and the angular range for the x-ray incidence [see inset in Fig. 1(a)].

22 Core-level photoemission intensities from every constituent element of the superlattice (La
23 4*d*, Ni 3*p*, Ca 2*p*, Mn 3*s*, O 1*s* and C 1*s*) were recorded as a function of grazing incidence angle



FIG. 2. (a) Schematic diagram of the investigated superlattice structure consisting of fifteen LaNiO<sub>3</sub>/CaMnO<sub>3</sub> bilayers, grown epitaxially on a single-crystal LaAlO<sub>3</sub> substrate, with each bilayer consisting of 4 unit cells of LaNiO<sub>3</sub> and 4 unit cells of CaMnO<sub>3</sub>. An excitation photon energy of 832.8 eV, corresponding to the onset of the La  $3d_{5/2}$  absorption threshold, was utilized for the photoemission experiments to enhance the standing-wave modulation amplitude at the Bragg condition. (b) Experimental core-level photoemission intensity rocking curves for all elements in the superlattice and (c) best theoretical fits to the data.

from 11.7° to 16.2° [see Fig. 2(b)] and self-consistently fitted using an x-ray optical theoretical 1 2 code [36], which accounts for the differential photoelectric cross-section as well as the inelastic 3 mean-free paths of photoelectrons inside the sample. Only the thicknesses of the CaMnO<sub>3</sub> and 4 LaNiO<sub>3</sub> layers and the interdiffusion between them were allowed to vary in the model. The x-ray optical constants needed for the calculations were obtained via XAS and Kramer-Kronig analysis 5 6 [34]. Fig. 2(c) shows the best theoretical fits to the experimental data, exhibiting excellent 7 agreement in terms of the amplitudes, relative phases and shapes. Surface-adsorbed CO<sub>x</sub> contaminate from the exposure to atmosphere provides an excellent depth reference (black 8 spectrum), thus further constraining the fitting and the calculations. 9

A detailed structure of the topmost layers derived from the experiment, as well as the simulated intensity of the x-ray standing-wave electric field (*E*<sup>2</sup>) as a function of depth inside the sample and of x-ray incidence angle, are shown in Fig. 3(a) and were obtained by using the set of best-fit parameters. Resultant thicknesses of the 4 u.c.-thick layers of LaNiO<sub>3</sub> (15.55 Å) and CaMnO<sub>3</sub> (14.80 Å) are consistent with the unit cell thicknesses of 3.89 Å (LaNiO<sub>3</sub>) and 3.73Å (CaMnO<sub>3</sub>), reported previously in the literature [37-39].

The  $E^2$  profile simulation shown in Fig. 3(a) indicates that at lower incidence angles 7 (yellow vertical line at  $\sim 13.3^{\circ}$ ) the two antinodes of the standing wave highlight predominantly 8 the top and the bottom interfaces of the  $CaMnO_3$  film (regions marked with letters 'a'), while the 9 10 middle 'bulk-like' section of the film resides in the dark region (SW node). With increasing incidence angle, the top antinode propagates downward into the CaMnO<sub>3</sub> layer spreading over 11 almost the entire 4 unit-cells at around 14.4° (marked with another yellow vertical line) with the 12 maximum intensity at approximately the center of the layer (region marked with letter 'b'). Such 13 contrasting angle-dependent depth distribution of the probing x-ray E-field intensities within the 14 sample enables clear differentiation between the bulk-like and interface-like species of Mn in the 15 CaMnO<sub>3</sub> layer, as well as a particular sensitivity to the interface-like Ni in the LaNiO<sub>3</sub> buried 16 layer. Importantly, the simulation results indicate that the standing-wave contrast within the 17 topmost layers of the sample is strong, reaching maximum difference of approximately 53% 18 between the values of  $E^2$  in the nodes and antinodes of the SW [see the color scale in Fig. 3(a)]. 19 20 Additional line-cuts, showing *E*-field intensity profiles at several key incidence angles are shown 21 in Fig. S1 in the Supplemental Material section [40].

In order to determine the valence-state profiles of the key cations, we examine the lineshapes of the Mn 3s and Ni 3p core-level spectra at the x-ray grazing incidence angles



FIG. 3. (a) Simulated intensity of the x-ray standing-wave electric field ( $E^2$ ) inside the superlattice as a function of depth (vertical axis) and x-ray grazing incidence angle (horizontal axis). Calculated layer thicknesses shown on the right are consistent with the 4× multiples of the LaNiO<sub>3</sub> and CaMnO<sub>3</sub> unit-cell constants reported in the literature [37-39]. (b) Depth dependent evolution of the Mn 3*s* multiplet splitting (in eV) as a function of the x-ray grazing incidence angle. (c) and (d) Mn 3*s* core-level photoemission spectra recorded in the interface-sensitive (~13.3°) and bulk-sensitive (~14.4°) experimental geometries, respectively. (e) Difference spectrum obtained by subtracting the spectrum obtained at ~13.3° (c) from that obtained at ~14.4° (d). (f) Plot of the relative Ni<sup>2+</sup> peak(s) intensity as a function of x-ray grazing incidence angle. (g) and (h) Ni 3*p* core-level photoemission spectra recorded at ~13.35° and ~13.95° respectively. (i) 'Bulk - interface' difference spectrum obtained by subtracting the spectrum obtained at ~13.35° (g) from that obtained at ~13.95° (h).

corresponding to the interface-sensitive and bulk-sensitive standing-wave configurations.
 Conventional photoemission spectra for typical bulk-like stoichiometric or near-stoichiometric
 CaMnO<sub>3</sub> and LaNiO<sub>3</sub> thin films are provided for reference in the Supplemental Material section
 (Fig. S2).

Fig. 3(b) depicts the depth-dependent evolution of the Mn 3*s* core-level multiplet splitting (in eV) as function of x-ray incidence angle. The magnitude of the 3*s* splitting decreases monotonically with the increase of the formal valency of the Mn cation [41,42], and is thus often used as a reliable and highly sensitive experimental observable for determining the Mn valence
state [21,42]. In the CaMnO<sub>3</sub>-interface sensitive experimental geometry, at the x-ray incidence
angles between 13.2° and 13.5° (corresponding to region 'a' in the sample), the average splitting
is estimated to be 4.95 eV, after self-consistent Shirley-background subtraction and peak-fitting
(see Fig. 3(c)). This value of splitting corresponds to the formal Mn valency of approximately
+3.4 [41], thus suggesting a mixture of Mn<sup>+3</sup> and Mn<sup>+4</sup> cations, with predominantly Mn<sup>3+</sup> ion
content at the interface.

For higher x-ray incidence angles, as the SW antinode propagates toward the center of the CaMnO<sub>3</sub> layer [as shown in Fig. 3(a)], the Mn 3*s* splitting gradually decreases, reaching a value of 4.76 eV [see Fig. 2(c)] in the CaMnO<sub>3</sub>-bulk sensitive geometry, at the incidence angle of  $\sim$ 14.4° (corresponding to region 'b' in the sample). For this magnitude of the 3*s* splitting, formal valency of the Mn cations is estimated to be approximately +3.6 [41], which suggests an increase of the Mn<sup>+4</sup> ion concentration (as in stoichiometric CaMnO<sub>3</sub>) toward the bulk of the layer.

The difference spectrum in Fig. 3(e), comparing Mn 3*s* spectra in the interface-sensitive and bulk-sensitive experimental geometries, exhibits a lineshape that is typical of the increasing splitting, with positive incursions at 82 eV and 88 eV and a negative dip emerging between the two separated multiplet components. The observed change in the Mn 3*s* splitting (190 meV) is approximately a factor of two larger as compared to the total experimental energy resolution (~100 meV).

20 Conventional surface-sensitive XPS spectrum recorded with the same photon energy but 21 away from the Bragg condition shows that the value of the Mn 3*s* splitting measured near the 22 surface is 4.81 eV, which is close to the bulk-like value of 4.76 eV (see Fig. S3 in the 23 Supplemental Material section). The splitting increases significantly to 4.95 eV (becomes more Mn<sup>3+</sup>-like) only when the additional standing-wave intensity highlights the bottom (buried)
 interface with LaNiO<sub>3</sub>.

In summary, our experimental SW-XPS results, in conjunction with x-ray optical 3 modeling, indicate an increased concentration of Mn<sup>3+</sup> cations in the interfacial regions of the 4 5 CaMnO<sub>3</sub> film. Evidence of such charge reconstruction has been observed indirectly in prior studies using depth-averaging techniques [13,15]. There are two possible sources of  $Mn^{3+}$  at the 6 interfaces: the leakage of itinerant electrons from the LaNiO<sub>3</sub> to the CaMnO<sub>3</sub> and the segregation 7 of oxygen vacancies in CaMnO<sub>3</sub> to the interfaces. The temperature-dependent resistivity data 8 suggests the onset of metallicity in superlattices with 4 u.c.-thick LaNiO<sub>3</sub> layers, with 9 increasingly lower resistivities in superlattices with thicker LaNiO<sub>3</sub> layers (e.g. 6 - 8 u.c. - see 10 Fig. 2 in Ref. [15]), and therefore the mechanism of the leakage of itinerant electrons from 11 LaNiO<sub>3</sub> into the first CaMnO<sub>3</sub> layer is the likely explanation in our superlattice. With increasing 12 metallicity of the LaNiO<sub>3</sub> layers, the emergent interfacial ferromagnetism is dominated by the 13 Mn<sup>4+</sup>-Mn<sup>3+</sup> double exchange interaction mediated by the leakage of the itinerant electrons and 14 not Ni<sup>2+</sup>-O-Mn<sup>4+</sup> superexchange interactions. 15

Mn<sup>3+</sup>-Mn<sup>4+</sup> disproportionation at the interface is predicted to stabilize Mn<sup>4+</sup>-Mn<sup>3+</sup> doubleexchange ferromagnetism, various signatures of which have been observed via bulk magnetometry, polarization-dependent XAS, and polarized neutron reflectometry (PNR) [13,15]. The latter technique provides a depth-resolved profile of magnetization in the superlattice and has shown that ferromagnetism in the CaMnO<sub>3</sub> film is confined to one unit-cell at the interface with LaNiO<sub>3</sub>, in agreement with our conclusions [13]. Our depth-resolved SW-XPS results thus provide a direct experimental link between the emergent magnetic and electronic interfacial properties and represent strong evidence to support the model of Mn<sup>4+</sup>-Mn<sup>3+</sup> double-exchangemediated ferromagnetism in the LaNiO<sub>3</sub>/CaMnO<sub>3</sub> superlattices.

The emergence of interfacial ferromagnetism mediated by the Ni<sup>2+</sup>-O-Mn<sup>4+</sup> superexchange 3 interactions requires the presence of off-stoichiometric Ni<sup>2+</sup> cations at the interface. In Figs. 3(f)-4 5 (i), we show the depth-dependent evolution of several features of the Ni 3p core-level peak, which have been used in numerous prior studies to determine the Ni valence state in LaNiO<sub>3</sub> 6 [43,44] and related compounds [45]. We label these components A-D in Fig. 3(g), in accordance 7 with the convention used by Qiao et al. [see Fig. S2(b) from Ref. [43]]. Features A and C can be 8 assigned to the Ni<sup>2+</sup>  $3p_{3/2}$  and Ni<sup>3+</sup>  $3p_{3/2}$ , respectively; while B and D are their  $3p_{1/2}$  counterparts 9 [43]. 10

It is immediately apparent from Figs. 3(g)-(h) that the Ni<sup>2+</sup> components (A and B) are more 11 intense, as compared to the Ni<sup>3+</sup> peaks (C and D). However, it is important to note that due to the 12 inelastic attenuation of the photoelectrons in the buried LaNiO<sub>3</sub> layer, at the photon energy of 13 14 832.8 eV we are mostly sensitive to the top-most 'interface-like' region of the film. In fact, with the inelastic mean-free path estimated at  $\sim 15$  Å [46], intensity of the photoemission signal from 15 the central 'bulk-like' region of the film is diminished by approximately 40%, compared to the 16 17 photoemission signal originating from the top LaNiO<sub>3</sub>/CaMnO<sub>3</sub> interface [46,47]. Thus, from the first evaluation of the 3p spectral lineshapes in Figs. 3(g)-(h), we can conclude that the interface 18 region of the buried LaNiO<sub>3</sub> film contains a significant concentration of the Ni<sup>2+</sup> cations. For 19 20 measurements carried out at incidence angles that are sufficiently far away from the Bragg condition to ensure almost uniform illumination of the film (12.5°-13.3°, or region 'c' in Fig. 21 3(a)), the relative intensity ratio (RIR) of the Ni<sup>2+</sup> peak components to the total 3p intensity is 22 23 estimated to be  $\sim 0.71$  [see Fig. 3(f)].



FIG. 4. Individual standing-wave rocking-curve modulations for the Ni<sup>2+</sup> (blue) and Ni<sup>3+</sup> (green) components of the Ni 3*p* core-level spectrum shown in Fig. 3(g). A relative shift of approximately  $+0.3^{\circ}$  of the Ni<sup>3+</sup> component with respect to the Ni<sup>2+</sup> component corresponds to a 3.2 Å (~1 u.c.) increase in the depth position of the SW probe inside of the LaNiO<sub>3</sub> layer. Circles correspond to experimental data and solid lines correspond to guides-to-the-eye obtained via polynomial fitting of the data.

Remarkably, in the Bragg condition, a SW node (dark spot) appears at the 1 LaNiO<sub>3</sub>/CaMnO<sub>3</sub> interface at ~13.35° and propagates into the LaNiO<sub>3</sub> layer, thus suppressing the 2 3 signal from the interface with a maximum effect at approximately 14.0° (region 'd' in Fig. 3(a)). Within the same angular range of  $\sim 13.3^{\circ}-14.0^{\circ}$ , an antinode (bright spot) appears in the central 4 region of the film, thus enhancing the signal from the 'bulk-like' LaNiO<sub>3</sub>. Our data in Fig. 3(e) 5 6 reveals that such enhancement of the 'bulk-like' signal (and simultaneous suppression of the 'interface-like' signal) results in a significant drop of the Ni<sup>2+</sup> RIR and an increase in the relative 7 Ni<sup>3+</sup> peak intensities. A difference plot, comparing Ni 3p spectra in the interface-sensitive and 8 bulk-sensitive experimental geometries highlights this depth-dependent disproportionation of the 9 Ni valence states [Fig. 3(i)]. 10

An effective way of confirming the above described depth-dependent disproportionation of the Ni species within the LaNiO<sub>3</sub> layer is to compare the lineshapes of the rocking curves (RC) for the Ni<sup>2+</sup> (A+B - blue) and Ni<sup>3+</sup> (C+D - green) individual components. Fig. 4 reveals a clear shift to a higher grazing incidence angle of the entire Ni<sup>3+</sup> component RC, relative to the Ni<sup>2+</sup>
RC. Such angular shift (estimated at approximately 0.3°) corresponds to a ~3.2 Å (about 1 unitcell) increase in the depth position of the SW probe inside of the LaNiO<sub>3</sub> layer. Thus, the
difference in the angular characteristics of the rocking curves in Fig. 4 suggests that the Ni<sup>2+</sup>
components of the Ni 3*p* spectrum originate mainly from the interfacial region with CaMnO<sub>3</sub>,
while the Ni<sup>3+</sup> signal comes mainly from the deeper 'bulk-like' LaNiO<sub>3</sub> layers.

Evidence of such interfacial charge redistribution has been observed in a prior combined 7 XAS and resonant soft x-ray scattering study on similar superlattices [15] and is consistent with 8 the polar compensation picture [15,22], wherein polar mismatch at the LaNiO<sub>3</sub>/CaMnO<sub>3</sub> 9 interface leads to interfacial Ni<sup>2+</sup> cations in the polar LaNiO<sub>3</sub> layer through the formation of 10 oxygen vacancies. The ensuing interaction between the interfacial  $Ni^{2+}$  and adjacent  $Mn^{4+}$  on the 11 CaMnO<sub>3</sub> side of the interface is predicted to stabilize the ferromagnetic ground state via the 12 superexchange mechanism [48,49]. Our depth-resolved SW-XPS results support this model and 13 suggest that this interaction is likely confined to a narrow (1 unit-cell) region at the interface. 14

15 In conclusion, in this study we used SW-XPS in conjunction with x-ray optical modeling to determine the valence-state profile of the Mn and Ni cations at an atomically-abrupt epitaxial 4 16 u.c. LaNiO<sub>3</sub> / 4 u.c. CaMnO<sub>3</sub> interface - a potential building-block for next-generation spintronic 17 devices. By looking at the depth-resolved evolution of the spectral lineshapes of the Mn 3s and 18 Ni 3p core levels, we observed an increased concentration of  $Mn^{3+}$  and  $Ni^{2+}$  cations at the buried 19 interface. Concomitantly, the 'formal valence' cations (Mn<sup>4+</sup> and Ni<sup>3+</sup>) were shown to be more 20 21 abundant in the 'bulk-like' regions of the respective films. The observed depth-dependent charge 22 redistribution creates an electronic environment favorable for the emergence of interfacial ferromagnetism mediated via the Mn<sup>4+</sup>-Mn<sup>3+</sup> ferromagnetic double exchange and Ni<sup>2+</sup>-O-Mn<sup>4+</sup> 23

superexchange mechanisms. The competition between these two mechanisms can be influenced
by tuning the thickness of the LaNiO<sub>3</sub> layer, which undergoes a metal-insulator transition in the
ultrathin limit (<4 u.c.), resulting in the thickness-dependent controllability of the magnetic</li>
moment at the interface as demonstrated in a prior study [15].

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